

PATENT / 10756-2222

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

In re P	ATENT application of:)		
Shunpe	ei YAMAZAKI et al.)	Art Unit: 2813	
Applic	ation No.: 09/699,466)	Examiner: T. NGUYEN	
Filed:	October 31, 2000)	T.	
For:	METHOD FOR FABRICATING A SEMICONDUCTOR DEVICE	A)	DEC 31 20 2800 T.AIL	RECEIV
	A	<u>MENDMENT</u>	2001 L ROC	
Commissioner of Patents Washington, D.C. 20231			December 26, 20	01

Dear Sir:

In response to the Examiner's non-Final Office Action mailed September 26, 2001, please consider the following amendments and remarks in connection with the above-identified application.

IN THE CLAIMS:

Please add the following new claims 26-34 as follows:

--26 A method for manufacturing a thin film transistor, comprising the steps of:

forming a semiconductor film on an insulating surface;

crystallizing said semiconductor film;

forming a semiconductor island having a tapered shape by patterning said semiconductor film, said tapered shape having an angle within a range of 20° to 50° between a side thereof and an underlying surface;

irradiating laser light to said semiconductor island; and forming an insulating film on said semiconductor island.

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